

Notice of References Cited	Application/Control No. 10/525,182		Applicant(s)/Patent Under Reexamination WEITBRUCH ET AL.	
	Examiner PAULOS M. NATNAEL		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,836,630	11-1998	Putnam, Jr., Ronald Glenn	294/50.5
*	B	US-5,835,630	11-1998	Schweid et al.	382/173
*	C	US-5,617,135	04-1997	Noda et al.	348/14.12
*	D	US-7,375,760	05-2008	Kempf et al.	348/441
*	E	US-7,158,107	01-2007	Kawabe et al.	345/89
*	F	US-5,959,693	09-1999	Wu et al.	348/624
*	G	US-7,006,255	02-2006	Sun et al.	358/3.27
*	H	US-5,512,956	04-1996	Yan, Li	348/606
*	I	US-5,724,098	03-1998	Murakami et al.	348/416.1
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.